RENESAS

µPA2375T1P N-CHANNEL MOSFET FOR SWITCHING

R07DS0573EJ0100 Rev.1.00 Dec 05, 2011

DESCRIPTION

The μ PA2375T1P is a switching device, which can be driven directly by a 2.5 V power source.

The μ PA2375T1P features a low on-state resistance and excellent switching characteristics, and is suitable for single cell LiB application.

FEATURES

- 2.5 V drive available
- Ultra low on-state resistance
 - $R_{SS(on)1} = 11.4 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.5 \text{ V}, I_S = 5 \text{ A})$
 - $R_{SS(on)2} = 12.4 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.0 \text{ V}, I_S = 5 \text{ A})$
 - $R_{SS(on)3} = 13.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 3.8 \text{ V}, I_S = 5 \text{ A})$
 - $R_{SS(on)4} = 17.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 3.1 \text{ V}, I_S = 5 \text{ A})$
 - $R_{SS(on)5} = 23.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 2.5 \text{ V}, I_S = 5 \text{ A})$
- Built-in G-S protection diode against ESD

ORDERING INFORMATION

| Part No. | Lead Plating | Packing | Package |
|--------------------------------|--------------|------------------|-----------------|
| μPA2375T1P-E1- Α ^{*1} | Ni/Au | Reel 5000 p/reel | 6-pin EFLIP-LGA |

Note: *1. Pb-free (This product does not contain Pb in the external electrode and other parts.)

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

| ltem | Symbol | Ratings | Unit |
|--|-----------------------|-------------|------|
| Source to Source Voltage ($V_{GS} = 0 V$) | V _{SSS} | 24.0 | V |
| Gate to Source Voltage (V _{DS} = 0 V) | V _{GSS} | ±12.0 | V |
| Source Current (DC) *1 | I _{S(DC)} | ±10 | A |
| Source Current (pulse) *2 | I _{S(pulse)} | ±100 | А |
| Total Power Dissipation (2 units) *1 | P _{T1} | 1.75 | W |
| Channel Temperature | T _{ch} | 150 | ۵° |
| Storage Temperature | T _{stg} | -55 to +150 | °C |

Note: *1. Mounted on ceramic board (50 cm² \times 1.0 mmt)

*2. PW \leq 10 μ s, Duty Cycle \leq 1%



| Characteristics | Symbol | MIN. | TYP. | MAX. | Unit | Test Conditions |
|----------------------------------|----------------------|------|------|------|------|--|
| Zero Gate Voltage Source Current | I _{SSS} | | | 1 | μA | V_{SS} = 24 V, V_{GS} = 0 V, TEST CIRCUIT 1 |
| Gate Leakage Current | I _{GSS} | | | ±10 | μA | V_{GS} = ±12 V, V_{SS} = 0 V, TEST CIRCUIT 2 |
| Gate to Source Cut-off Voltage | V _{GS(off)} | 0.5 | 0.9 | 1.5 | V | V_{SS} = 10 V, I_S = 1.0 mA, TEST CIRCUIT 3 |
| Forward Transfer Admittance *1 | y _{fs} | 7.0 | | | S | V_{SS} = 5 V, I_S = 5 A, TEST CIRCUIT 4 |
| Source to Source On-state | R _{SS(on)1} | 6.5 | 9.0 | 11.4 | mΩ | V_{GS} = 4.5 V, I _S = 5 A, TEST CIRCUIT 5 |
| Resistance ^{*1} | R _{SS(on)2} | 6.5 | 9.6 | 12.4 | mΩ | V_{GS} = 4.0 V, I _S = 5 A, TEST CIRCUIT 5 |
| | R _{SS(on)3} | 6.5 | 9.8 | 13.0 | mΩ | V_{GS} = 3.8 V, I_S = 5 A, TEST CIRCUIT 5 |
| | R _{SS(on)4} | 7.0 | 11.5 | 17.0 | mΩ | V_{GS} = 3.1 V, I_S = 5 A, TEST CIRCUIT 5 |
| | R _{SS(on)5} | 9.0 | 15.0 | 23.0 | mΩ | V_{GS} = 2.5 V, I_S = 5 A, TEST CIRCUIT 5 |
| Input Capacitance | C _{iss} | | 2250 | | pF | V _{SS} = 10 V, |
| Output Capacitance | C _{oss} | | 670 | | pF | $V_{GS} = 0 V,$ |
| Reverse Transfer Capacitance | C _{rss} | | 510 | | pF | f = 1.0 MHz, TEST CIRCUIT 7 |
| Turn-on Delay Time | t _{d(on)} | | 6.6 | | μs | V _{DD} = 20 V, I _S = 10 A, |
| Rise Time | tr | | 44 | | μs | V _{GS} = 4.0 V, |
| Turn-off Delay Time | t _{d(off)} | | 72 | | μs | R _G = 6.0 Ω, |
| Fall Time | t _f | | 133 | | μs | TEST CIRCUIT 8 |
| Total Gate Charge | Q _G | | 40 | | nC | V_{DD} = 19.2 V, V_{G1S1} = 4.0 V, I_S = 3 A, |
| | | | | | | TEST CIRCUIT 9 |
| Body Diode Forward Voltage *1 | V _{F(S-S)} | | 0.9 | | V | I_F = 10 A, V_{GS} = 0 V, TEST CIRCUIT 6 |

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)

Note: *1. Pulsed test

Both the FET1 and the FET2 are measured. Test circuits are example of measuring the FET1 side.





μ**PA2375T1P**



Is - Source Current - A







 V_{SS} - Source to Source Voltage - V









V_{SS} - Source to Source Voltage - V

GATE TO SOURCE CUT-OFF VOLTAGE

FORWARD TRANSFER CHARACTERISTICS



Is - Source Current - A

y_{is} | - Forward Transfer Admittance - S

3

V_{GS} - Gate to Source Voltage - V







SOURCE TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



V_{GS} - Gate to Source Voltage - V

Is - Source Current - A





0.2

0

-50

0



50

 $I_{D} = 1.0 \text{ mA}$

100

150





 $R_{ss(on)}$ - Source to Source On-state Resistance - $m\Omega$

 $R_{\text{SS(on)}}$ - Source to Source On-state Resistance - $m\Omega$

 $t_{d(on)}, t_r, t_{d(off)}, t_f$ - Switching Time - μ s



SOURCE TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE







SOURCE TO SOURCE DIODE FORWARD



 $V_{F(S-S)}$ - Source to Source Voltage - V

CAPACITANCE vs. SOURCE TO SOURCE VOLTAGE



V_{SS} - Source to Source Voltage - V

DYNAMIC INPUT CHARACTERISTICS



Q_G - Gate Charge - nC



V_{GS} - Gate to Source Voltage - V

Example of application circuit

Li-ion battery (1 cell) protection circuit





PACKAGE DRAWINGS (UNIT: mm)

6-pin EFLIP-LGA



Equivalent Circuit





USAGE CAUTIONS

When you use this device, in order to prevent a customer's hazard and damage, use it with understanding the following contents. If used exceeding recommended conditions, there is a possibility of causing the device and characteristic degradation.

- 1. This device is very thin device and should be handled with caution for mechanical stress. The distortion applied to the device should become below 2000×10^{-6} . If the distortion exceeds 2000×10^{-6} , the characteristic of a device may be degraded and it may result in failure.
- 2. Please do not damage the device when you handle it. The use of metallic tweezers has the possibility of giving the wound. Mounting with the nozzle with clean point is recommended.
- 3. When you mount the device on a substrate, carry out within our recommended soldering conditions of infrared reflow. If mounted exceeding the conditions, the characteristic of a device may be degraded and it may result failure.
- 4. When you wash the device mounted the board, carry out within our recommended conditions. If washed exceeding the conditions, the characteristic of a device may be degraded and it may result in failure.
- 5. When you use ultrasonic wave to substrate after the device mounting, prevent from touching a resonance directly. If it touches, the characteristic of a device may be degraded and it may result in failure.
- 6. Only the epoxy resin of the semiconductor grade is recommended as coating material.
- 7. Please refer to Figure 2 as an example of the Mounting Pad. Optimize the land pattern in consideration of density, appearance of solder fillets, common difference, etc in an actual design.
- 8. The marking side of this device is an internal electrode. Please neither contact with terminals of other parts nor take out the electrode.

Figure 1 Recommended soldering conditions of INFRARED REFLOW



Infrared Reflow Temperature Profile







Figure 3 The unit orientation





| Revision History | |
|-------------------------|--|
|-------------------------|--|

μ PA2375T1P Data Sheet

| | | Description | | |
|------|--------------|-------------|----------------------|--|
| Rev. | Date | Page | Summary | |
| 1.00 | Dec 05, 2011 | - | First Edition Issued | |

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